

Search Notes**Application/Control No.**

10/539,716

**Applicant(s)/Patent under
Reexamination**

HATRICK-SMITH ET AL.

Examiner

Huyen Le

Art Unit

3751

SEARCHED

Class	Subclass	Date	Examiner
4	541.1- 541.6	11/19/2009	HL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR